Fault-aware Hardware Scheduling of Computations in Deep Neural Networks

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Abstract: The idea of using inexact computation for overprovisioned DNNs (Deep Neural Networks) to extract power savings and performance gains at the cost of minor performance degradation has become very popular. However, there is still no general method to schedule the DNN computations on a given hardware platform to effectively implement this idea without loss in computational efficiency. Most contemporary methods require extensive retraining, specialized hardware and hardware-specific scheduling schemes. We present *HAS: Hardware Agnostic Scheduler* for scheduling DNN computations in heterogeneous and faulty hardware. Given a trained DNN model and a hardware fault profile, our scheduler is able to recover significant performance even at high fault rates. HAS schedules the computations such that the low priority ones are allocated to inexact hardware. Since most DNN computations are matrix multiplications, it achieves this by shuffling (exchanging) the rows of the matrices. The best shuffling order for a given DNN model and hardware faulty profile is determined using Genetic Algorithms (GA). We simulate bitwise errors on different model architectures and datasets with different types of fault profiles and observe that HAS can recover up to 30% of classification accuracy even at high fault rates (which correspond to approximately 50% power savings).

Keywords: Genetic Algorithms, Deep Neural Networks, Fault-tolerance, AI Accelerator

1. Introduction

Deep Neural Networks (DNNs) have become very successful for a wide range of applications in research and industry. There is a large body of research focusing on accelerating DNNs with specialized hardware (such as GPUs and TPUs) to overcome the resource constraints (e.g., power, computation) of real world applications. Since the majority of computations for DNNs are embarrassingly parallel, the current trend has been to develop accelerators with a large number of Processing Elements (PEs) that operate in SIMD mode. For e.g., NVIDIA GPUs contain CUDA cores/threads that operate in parallel and which are arranged in Streaming Multiprocessor (SM) blocks.

Many of the new DNN accelerators have very densely packed chips/chiplets in various novel architectural organizations (e.g., Google's Tensor Processing Units (TPUs), SambaNova's Datascale Systems, Cerebras's Wafer-Scale Engine (WSE), Tesla's Dojo D1 etc.). However, with current nanometer process technologies, yield and reliability are drastically reduced. Disposing entire chips due to the presence of a few faulty PEs is impractical. Adding error correction mechanisms and redundancies to maintain worst-case margins further drives up the power and cost. In addition, chips also degrade with time and external factors causing some PEs to be more faulty than others. Therefore we cannot assume accelerators to be perfectly reliable all the time.

Motivation: Although the reliability of accelerators is a ma-

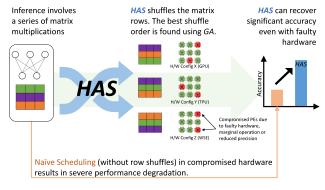


Fig. 1 DNN models deployed in the field are implemented in different hardware configurations that tradeoff efficiency for inexact computation. HAS schedules the DNN computations using a black-box approach to recover performance in compromised hardware.

jor issue, DNNs have inherent algorithmic resilience to errors on account of their distributed parallel nature and over-provisioned parameters. They have been shown to be fault tolerant to Bit Error Rates (BERs) as high as 10^{-4} (in contrast to conventional systems that require BERs in the order of 10^{-15}) [4,5]. It is therefore possible to salvage performance of DNNs even with faulty hardware. In fact, the approximate computing and machine learning (ML) research community have cleverly leveraged this resiliency of DNNs. By relaxing computational exactness, they have been able to increase energy efficiency and reduce computational latency at the cost of minor performance degradation. Some popular methods are i) to reduce the supply voltage in SRAM cells to maximize energy efficiency [1, 5] and ii) use low-power approximate arithmetic hardware [1, 11]. Reducing computation

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precision for lower latency, memory usage and energy consumption [7, 9, 11] has also gained major attention. In fact, it has become very common for DNN accelerators to have a mixture of heterogeneous PEs with different precision [8].

The general method is to first identify unimportant neurons and then schedule them on compromised hardware. *1 While studying the sensitivity of neurons to computational errors is interesting in its own right, it does not help very much when implementing DNNs on accelerators. This is because optimized code breaks the conceptual one-to-one mapping between a neuron and its computations. For e.g., in the case of GPUs, the computations corresponding to any one neuron is actually spread out across multiple CUDA threads to maximize throughput. This is achieved by block-tiling methods used widely in GEMM (General Matrix Multiply) libraries. As a result, many CUDA cores participate in the calculation of one neuron and CUDA cores are reused extensively by different neurons. The scheduling therefore must focus on allocating unimportant computations (not neurons) on compromised hardware. In this light, scheduling faulty hardware to DNN computation becomes very difficult (due to the resulting large combinatorial optimization search space). Existing solutions are not general because they make strong assumptions about the DNN model and hardware [7].

Proposal: Given the variety of DNN models, accelerators and types of fault profiles that may manifest in hardware, it is important to have a hardware-agnostic method for scheduling computations on faulty hardware. We propose HAS: Hardware Agnostic Scheduler to schedule DNN computation in faulty hardware to reduce the effect of faults and recover model performance. HAS achieves this by shuffling the rows of the matrices during multiplication. This gives it some control over where the computations are allocated in the hardware. HAS uses Genetic Algorithm (GA) to search the huge optimization space for the best shuffling order such that the majority of the critical operations are assigned to robust computation units. Row-shuffling, while simple, is a general methodology for performance recovery that treats the DNN model as a black box. It does not alter the semantics so code redesign in not necessary. Neither does it interfere with the optimized dataflow graphs specific to different microarchitectures. It also has extremely low computational and time complexity and can be applied to a vast variety of DNNs.

In this paper, we focus only on inference. Learning the weights of a DNN model is a one-time cost that is performed in a fault-free environment. Once trained, the same model is reused many times over in different hardware platforms with different fault profiles. The GA search to find a suitable shuffle order for a given hardware configuration is also a one-time cost and can be done offline. This requires a fault injection simulator (like in [4]) and the hardware fault profile to be known beforehand. These can be obtained via diagnostic tests and simulation.

This paper makes the following contributions:

 We develop HAS, a Hardware-Agnostic Scheduler that recovers lost performance of DNN models on faulty hard-

- ware by allocating unimportant computations to compromised PEs (Section 3). This is achieved by shuffling the rows of the matrices during multiplication. The row shuffle order is determined by GA search.
- We analyze the fault sensitivity of DNN models and their layers to different fault types and fault rates using bit-level fault injection (Section 5.1).
- We determine the most suitable row shuffle orders by using HAS on the most sensitive layers and recover significant performance (by as much as 30%) from the DNNs in compromised hardware (Section 5.2).

2. Related Work

A good overview of the different faults and errors in DNNs and how they can be made more robust is given in [6]. The authors identify stuck-at and random bit flips as the most widely and successfully used abstract fault models. So we focus mainly on the errors caused by these faults in this work. Our paper builds up on the work in [4,5]. In [4], the authors propose a bitwise faultinjection framework for DNNs to analyze the effect of fault-rate and performance degradation on different DNN models. They show that is possible to leverage implicit fault tolerance properties of DNNs to improve efficiency. In [5], this is demonstrated by lowering the SRAM voltages to improve energy performance at the cost of increasing fault rates. They also propose fault mitigation techniques by setting faulty bits/words to zero. The approximate computing community has also exploited the faulttolerance of DNNs by using low-power approximate arithmetic hardware [1, 11]. In [1, 7, 11], the authors characterize neuron sensitivity and approximate low priority neurons. The drop in performance is recovered by retraining the model. This is not a general methodology and is not always possible due to lack of access to datasets and computational resources. DNNs can also be made more robust by pruning and dropout. These solutions target individual neurons/weights, which as discussed before, is not how hardware faults generally map to the DNN computation. Our paper focuses on a bit-level fault-model which is more realistic.

Another popular direction for reducing power and latency has been to use reduced precision arithmetic. This is now widely supported by many ML frameworks and libraries. In [9], the authors propose an automated framework to determine the bitwidth required for different computations in a DNN. Their method uses a hardware-aware optimization loop to specialize for different hardware configurations. Other works such as [8] use specialized accelerator architectures with reducible precision for maximizing throughput and minimizing energy. The focus of our work differs from [8,9] in that it is hardware-agnostic and does not necessarily require hardware-in-loop during optimization for reduced precision.

3. Hardware Agnostic Scheduler (HAS)

3.1 Fault Models

A fault is defined as "an anomalous physical condition...which gives rise to an error" [6]. A fault may induce an error, which is a deviation of the logical state from the correct one. Permanent faults are continuous and always present, arising mostly due to

^{*1} We use the term"compromised hardware" as an umbrella term to indicate hardware that is faulty either due to manufacturing defects, marginal operation or reduced precision.

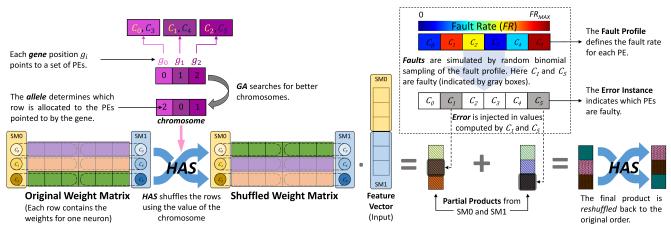


Fig. 2 Matrix-vector tiled multiplication is spread across two SM blocks and six CUDA cores. HAS shuffles the rows of the weight matrix, using the best genes from GA search. The most critical neuron/row (green) is allocated to the most robust cores (C_0 and C_3). As a result, the corresponding element of the final product vector (dark green) is not affected by the faults. The figure also illustrates our error-injection simulation strategy to simulate hardware faults.

irreversible physical damage. A transient fault occurs for a short period of time mostly due to process and environmental variations as well as degradation. Recurring transient faults are called *intermittent* faults and these are the most common types of faults. Intermittent faults are usually caused by marginal device operation.

We abstract the effects of these various faults using the following bitwise fault model similar to [4–6]:

- Flip-to-0/1: a random register bit is held at either 0/1.
- Bitflip: the value of a random register bit is flipped.

The Flip-to-0/1 fault model represents many of the permanent faults in hardware. The Bitflip fault models the transient faults in PE SRAM registers/memory elements due to marginal operation or external effects.

In addition to bitwise fault models, we also define a fault model for mixed-precision computations. Although reduced precision is not a result of an anomalous physical condition, we can model it as a type of marginal operation. By reducing computation precision, it is possible to reduce power and latency of the hardware significantly as shown in [9]. In this work, we model reduced precision as a type of fault where a block of the least significant bits of the mantissa are set to zero. We use this fault model for no other reason than for simplifying the description and analysis of our experiments.

3.2 Fault Injection Methodology

A bitwise fault model is much more realistic w.r.t. hardware implementation than a neuron-wise model. We further only consider faults that affect the intermediate computations of DNNs and not the main memory elements that contain the input data stream, weights and biases. The effects of errors in the weights and biases in the main memory and their mitigation have been addressed in [4, 5]. We assume that the input, weights and biases are not corrupted. This way if there is any degradation in model performance, it is solely due to incorrect computation and not corrupt data.

3.2.1 Tiled Matrix Multiplication

We focus on the effects of hardware faults on matrix multiplications because they constitute the majority of the computations for DNNs. Matrix multiplications consist of many multiply and accumulate (MAC) operations that can be performed in parallel. For general matrices, tiled matrix multiplication is preferred because it maximizes parallelization and minimizes memory conflicts by exploiting data locality. For instance, in nVIDIA GPUs, large multiplying matrices are broken up into small tiles and each tile is computed by a SM which consists of a *warp* of 32 CUDA threads/cores. The partial products from each of the blocks are summed together to give the final product. This is why we cannot assume one-to-one mapping between neurons and PEs for DNN accelerators. The calculation for one neuron is performed by multiple PEs and each PE is reused many times for different neurons (Figure 2).

We are interested in the effect of faulty behavior of the CUDA cores in the SM blocks. Hence we simulate faults by injecting errors separately into the *partial products* from each SM block. This fault-injection methodology is illustrated for the case of matrix-vector multiplication in Figure 2. Note that injecting errors *after* the final matrix product has been computed does not capture the faulty behavior of the CUDA cores in the SMs.

3.2.2 Fault Profiles and Error Instances

In this work, we assume the fault rate (FR) is the same as the error rate i.e., faults always result in errors. This is simply to make the analysis straightforward and has no loss of generality during analysis and experiments. We simulate faults in the GPU hardware using a bitwise fault simulator similar to [4]. The simulator injects errors into the computation executed by a PE with a probability that is determined by its fault rate (Figure 2). The fault profile of the accelerator (GPU) describes the different fault rates of its PEs (CUDA cores). At each time step, an error instance is sampled from the fault profile. The error instance determines whether or not if a particular PE is faulty.

3.2.3 *im2col* Optimization

Naive implementation of the convolution operation is ineffi-

cient. It is also easily one of the most compute intensive components of DNNs especially when there are multiple kernels and channels. A popular approach for implementing convolution operations is to flatten the kernel matrices, extract patches of the images into columns (*im2col*) and perform Multiple Channel Multiple Kernel (MCMK) convolution using existing GEMM libraries [2]. This decreases the latency of the convolutional operation at the expense of larger memory use. This method of convolution is the most widely used and is present in many of the popular deep learning frameworks. We assume convolution operations are optimized using *im2col* method and implemented as GEMM. Thus fault injection in convolution operation is similar to that for matrix-matrix/vector multiplications.

3.3 GA Problem Statement for HAS

The main objective of HAS is to achieve better scheduling of computation in faulty hardware to recover lost performance. HAS achieves this by shuffling the matrix rows before multiplication. After computation, it "reshuffles" the rows of the product back to the original order after so that the mathematical semantics are preserved. By permuting (shuffling) the order of the rows, we get some (limited) control over where these computation take place within the accelerator. The number of possible ways in which one can shuffle the rows of a matrix with n rows is n!. This is a huge optimization space and exhaustive brute force search is not possible. HAS uses GA search to find a suitable shuffle order. Exchanging rows does not have high computational/temporal complexity so the overhead is minimal for HAS. The row-exchange usually involves changes in the metadata of the tensor i.e., only the tensor "view" changes and no actual data is copied to/from the memory. When implemented this way, the temporal complexity is O(1). Furthermore, since all the rows for a PE block are usually loaded into a shared memory pool, row-exchanges do not increase the cache miss rates significantly.

3.3.1 Genetic Representation

GA is especially suitable for this search problem because it is highly parallelizable and defining the fitness functions and chromosomes is quite straightforward. *HAS* uses GA to find the row shuffle order for a given matrix multiplication for a known hardware fault profile. This is done offline. If the fault profile is not known beforehand, it can be obtained from diagnostic tests. If that is also not possible, one can run GA optimization online with the faulty hardware to find the best solution.

We define the chromosome to be an array of integers that represents the row-exchange order for the *multiplier* matrix. The length of the chromosome is equal to the number of rows of the matrix. The *genes* (i.e., the element positions of the chromosome) represents the PEs that compute the row indicated by the *allele* (i.e., the value of the gene). This means each gene position g_i maps to a set of PEs (CUDA cores) $S_i \in \{C_i, C_j, ...\}$. If g_i contains the allele (value) a_i , then row a_i of the multiplier matrix is scheduled to be computed by the PEs in S_i (Figure 2).

The mapping of genes to actual hardware is not in our control and is usually not known. However, this is not a problem as long as the internal scheduling of the accelerator is consistent. Consequently, our method is independent of the inner workings

of the accelerator. Of course, it is possible to get more control over the scheduling by accessing the accelerator firmware. However, this results in a highly specialized solution for a very specific hardware-DNN model pair for a very specific fault profile. This is not a general solution and usually not possible in proprietary hardware. Our method is agnostic to the microarchitecture of the accelerator hardware. If the fault profile changes, it is always possible to re-run the GA search find a suitable scheduling scheme (shuffle order) for *HAS*.

3.3.2 Fitness Function

A DNN model inference involves a number of matrix multiplications. We associate one chromosome for each matrix multiplication that is optimized by *HAS*. For a given fault profile and a set of chromosomes, the fitness function is simply the top-1 classification accuracy of the model when the computation is implemented on that hardware with the row shuffle orders as determined by the corresponding chromosomes. Every generation, the best *N* individuals from a population are selected to be parents. These parents generate new offspring through mutation and crossover. When the genetic information from two parents are recombined in a random manner to create a new solution, it is called *crossover*. During *mutation*, the genetic sequence is randomly and arbitrarily modified to bring diversity to the new generation of population. The fitness of the offspring is evaluated and the best *N* individuals become parents for the next generation.

4. Evaluation Setup

4.1 DNN models

We use two types of DNN models for evaluation: mnist32-cnn and fashion-cnn. mnist32-cnn consists of one convolutional layer (c0) with 32 (4×4) kernels followed by three dense layers (h0,h1,h2) and a final output layer (op). The model is trained using the MNIST dataset [3] with the images resized to 32×32 (for faster fault-injection simulation). fashion-cnn consists of two convolutional layers, c0 and c1, each with 32 (4×4) kernels. This is followed by two dense layers (h0) and (op). It is trained with dropout on the Fashion-MNIST dataset [10] with (op) whereas (op) (op)

We analyze the fault sensitivity of each of the model instances by injecting different types of errors into each of their layers oneby-one. If faults in a particular layer significantly degrade the performance, we use GA search to find the best chromosome (rowexchange order) for *HAS*.

4.2 Fault Profiles

We consider an nVIDIA GPU-based DNN accelerator for our experiments. This is simply for the sake of example and there is no loss in generality during fault-sensitivity analysis and recovery with *HAS*. We assume the GPU has 20 streaming multiprocessors (SMs) and each multiprocessor has 32 PEs (i.e., CUDA cores). We consider only 20 SMs per GPU to keep our simulations tractable. Each CUDA core has a fault rate i.e., probability of a fault manifesting and resulting in an error.

The probability distribution of the FR of each CUDA core is

Table 1 Different types of errors

Error	Description	Max. Fault Rate
Flip-to-0	Flip a random bit in the exponent to 0	1E-1, 2E-1, 5E-1
Flip-to-1	Flip a random bit in the exponent to 1	1E-3, 2E-3, 5E-3
BitFlip	Flip a random bit in the exponent	1E-3, 2E-3, 5E-3
TF32	Set the last 13 bits of mantissa to 0	1E-1, 2E-1, 5E-1
BF16	Set the last 16 bits of mantissa to 0	1E-1, 2E-1, 5E-1

determined by the *fault profile* of the GPU. We use six different types of fault profiles in our experiment and distinguish between them by the maximum fault probability (FR_{max}). Thus a GPU with a fault profile characterized by FR_{max} means that each of its CUDA cores have different fault probabilities (including zero for non-faulty PEs) but none exceed FR_{max} . At each timestep, each CUDA core is either faulty or non-faulty with a probability distribution that depends on its particular fault rate. We assume that faulty operation of the CUDA cores are independent events for the sake of generality; although in practice, there may be some strong correlation between the FRs of spatially neighbouring CUDA cores due to shared power/data bus, thermal hotspots etc.

For our evaluations, we generate artificial fault profiles of the GPU for a given FR_{max} by randomly assigning a $FR \in (0, FR_{max})$ for each CUDA core. For a given FR_{max} , we instantiate two different fault profiles using different seeds to represent different hardware profiles. These hardware profiles represent different types of hardware with manufacturing/aging defects, or the marginal behavior due to power optimization schemes, or heterogeneous PEs with reduced precision.

4.3 Error Types

At each time step, *error instances* are derived from the fault profile using random binomial sampling. Based on the fault model described in Section 3.1, we simulate five different types of errors. These errors and their corresponding FR_{max} are listed in Table 1. We are primarily interested in bitflips that happen only in the exponent field of the FP32 data because they affect the performance most strongly. Our preliminary evaluations show that bitflips in mantissa are not very serious because they do not cause large enough deviations from the correct value.

We also define mantissa truncation as an "error" for sake of consistency in description. While individual bitwise errors in mantissa are not very serious, truncating out a block of mantissa bits affects the performance of the model significantly [9]. TF32 and BF16 are popular truncation schemes used in DNN and ML frameworks. We emulate this reduced precision by setting some number of mantissa least significant bits to zero. Fault sensitivity analysis using TF32 and BF16 errors gives us an indication of how sensitive the DNN is to the precision offered by the mantissa bits and how much recovery can be expected. This scenario may arise in cases when the same model has to be implemented on different hardware platforms that contain a mixture of PEs that compute using different precision [8], and where hardware-inthe-loop optimization may not be practical. In such a case, we would like to know whether shuffling the rows using HAS can recover some of performance lost due to mixed precision arithmetic. For the sake of generality, we consider an extreme case

Table 2 Sizes of matrices in different layers

Model	Layer	Weights/Kernel Matrix	Input Matrix/Vector
mnist32-cnn	c0	32 × 16	$16 \times (29 \times 29)$
	h0	1024×6272	6272 × 1
	hI	256×1024	1024 × 1
	h2	64 × 256	256 × 1
	op	10×64	64 × 1
fashion-cnn	c0	32 × 16	$16 \times (28 \times 28)$
	cI	$32 \times (16 \times 32)$	$(16 \times 32) \times (32 \times 32)$
	h0	1024×1568	1568 × 1
	ор	10×1024	1024 × 1

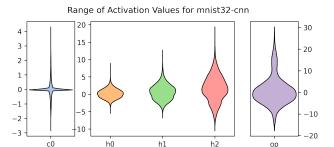


Fig. 3 The range and distribution of the matrix multiplication products in different layers for *mnist32-cnn* (before ReLU or softmax).

(i.e., a harder optimization problem) of a GPU with heterogeneous CUDA cores that randomly switch between different levels of precision (FP32, TF32 or BF16) with a fixed probability. Of course, this is unrealistic and in practice, the CUDA cores would be regularly arranged and their precision would be controlled deterministically.

4.4 Metrics and Evaluation Parameters

The performance of a model is measured by evaluating its classification accuracy on the test images (i.e., images not seen during training). Since errors manifest stochastically for a given fault profile, we evaluate the model three times with that profile and report its mean and standard deviation. The fitness function for the GA algorithm also uses the mean over three evaluations of the model for a given fault profile and shuffle order.

Each GA optimization run is performed three times and we use the best chromosomes out of each run (one run lasts for 100 generations). We limit the population size to 20 with a Crossover Rate (CR) at 0.6 and Mutation Rate (MR) of 0.2. During each generation, the fittest 20 individuals are selected for breeding and generating the next batch of individuals (truncation selection). This is faster than probabilistic selection like the Roulette wheel. Moreover, we observe that most individuals have very close fitness values so Roulette wheel type selection mechanisms are not worth the additional time and computation. The hyperparameters for GA were determined using a grid search. We use the same GA hyperparameters across all our experiments for consistency. However, there is much room for improvement if one were to use different hyperparameters depending on the model and the DNN layer. We leave this finer hyperparameter search problem for future work.

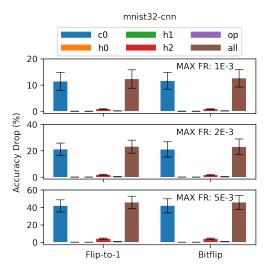


Fig. 4 Sensitivity of different layers to bitwise errors in the exponent field. Layer *c0* is most sensitive due to high kernel reuse.

5. Experimental Results

5.1 Fault Sensitivity Analysis

5.1.1 mnist32-cnn

Figures 4 and 5 show the fault sensitivity for different layers of mnist32-cnn. The figures report the mean and the standard deviation of the performance degradation across all model seeds and error profile seeds. In Figure 4, we observe that the classification accuracy degrades gracefully with increasing fault rates. This is encouraging because it shows that errors in computation do not automatically imply catastrophic failures in DNNs. For mnist32-cnn, layer c0 is the most sensitive to Flip-to-1 and Bitflip errors and contributes most to performance degradation. These observations concur with the results in [4]. The degradation becomes significant when fault rates exceed 5e-3.

We hypothesize that the reason behind c0's sensitivity to these errors is due to i) the limited range of the output of the convolution layer and ii) the high reuse of the kernel matrix. From Figure 3, we observe that the outputs of the convolution matrix multiplication (before ReLU activation) are tightly concentrated around 0. When an exponent bit is accidentally flipped to 1, the resulting error is quite large. If the change is in the positive direction, this error is propagated through the ReLU and maxpool layers and thus affecting the rest of the DNN computation pipeline. Secondly, from Table 2, we see that c0 convolution has a small kernel matrix which spans over a few PEs. These PEs are reused many times over the im2col patches extracted from the image. Thus, recurring errors in the PEs containing the kernel matrix are expressed many times during the convolution thus amplifying the effect of the error. The work in [4] also follows a similar reasoning.

In contrast, layers h0-h2 span over a large number of PEs due to their large sizes but are used only once for multiplying a feature vector (because inference is usually one image at a time). Hence, the errors in h0-h2 layers do not cause significant degradation. Among the fully connected layers, h2 is the most sensitive to Flip-to-1 and Bitflip errors. This is probably due to its proxim-

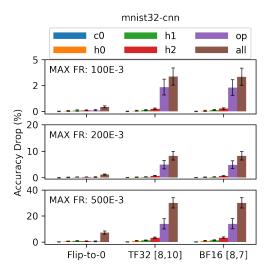


Fig. 5 Flip-to-0 errors are benign even at very high fault rates. Mantissa truncation affects output layer (*op*) the most severely.

ity to the output layer. Any bitwise errors in its exponent causes a large deviation resulting in wrong neurons being activated in the output layer.

In Figure 5, we observe that Flip-to-0 errors cause very little performance degradation (less than 5%) even at very high fault rates. This seems to hold true irrespective of the model and the layer in which this error manifests (see also Figure 6). In fact, the authors in [5] purposefully set bits to zero when error is detected, as a *fault-correction* technique. As stated in [5], only a few neurons fire at a time while the rest are inhibited. Since it is more probable that a neuron does not fire, a Flip-to-zero (which inhibits firing) is more benign that Flip-to-1 (which may activate accidental firing).

Truncating the LSBs of mantissa (TF32, BF16) does not cause dramatic degradation even at very high fault rates (Figure 5). This observation is in agreement with the idea behind aggressive precision reduction techniques used in [9]. Mantissa truncation errors affect output layer the most. It is interesting to note that the output layer is relatively more immune to Flip-to-1/Bitflip error than mantissa truncation when compared with the other layers.

We reason that this is due to the precision sensitivity of the final softmax activation as a result of the "squashing" effect of the exponential function in softmax. The product of the output layer matrix multiplication is a vector of ten elements (one for each image class). This vector is fed into the softmax activation which squashes them using an exponential followed by normalization. When the elements of the vector have similar values, he softmax operation is sensitive to the precision. Mantissa truncation reduces this precision and therefore introduces significant error into the final class scores. On the other hand, exponent bit errors result in very large changes that overwhelm the softmax output. However, since the *op* layer multiplication for *mnist32-cnn* requires only a few PEs, the overall effect of exponent bitwise errors is not very pronounced.

5.1.2 fashion-cnn

The fashion-cnn model has two convolutional layers. It is trained with multiple dropout layers and therefore it is more robust and can tolerate error rates almost two orders of magnitude

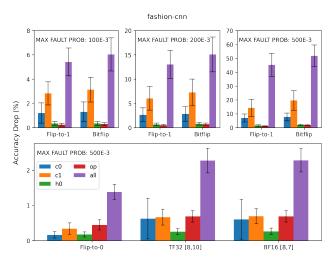


Fig. 6 fashion-cnn is more robust to errors. At FR_{max}=500e-3, c0 and c1 are most affected causing significant degradation.

higher than mnist32-cnn (Figure 6). Similar to mnist32-cnn, the convolutional layers c0 and c1 are most sensitive to Flip-to-1 and Bitflip errors. We reason that c1 is more sensitive than c0 due to larger kernel size and the more kernel reuse. Although the degradation due to only one of the convolutional layers is not very much, when both c0 and c1 have errors, the degradation can be very high.

The *fashion-cnn* model is very robust to mantissa truncation. Even at error rates as high as 0.5, the degradation is only a few percentage points. This indicates that the precision of PEs can be aggressively reduced without significant performance degradation.

5.2 Performance Recovery with HAS

Now that we have identified the which layers are most sensitive to which errors, we use our GA-based *HAS* and observe what performance can be salvaged. Specifically, we use *HAS* for

- *c0* layer in *mnist32-cnn* for Flip-to-1 and Bitflip errors $(FR_{max} = 1e-3, 2e-3, 5e-3)$.
- h2 and op layers in mnist32-cnn for mantissa truncation errors TF32 and BF16
 (FR_{max} = 100e-3, 200e-3, 500e-3).
- c0 and c1 layers in fashion-cnn for Flip-to-1 and Bitflip errors (FR_{max} = 500e-3).

Other layer-error combination scenarios have very little degradation so we can assume that they are effectively running on nonfaulty hardware. Of course, we cannot expect the performance to recover completely on faulty hardware but as we shall see, *HAS* comes pretty close.

5.2.1 mnist32-cnn

The stacked bar plots in Figure 7 show the performance degradation due to Flip-to-1 and Bitflip errors in $c\theta$ and the subsequent recovery by *HAS* using the shuffling order obtained from GA search.

We observe that HAS is able to recover almost 30% of the lost accuracy (from $\sim 55\%$ to $\sim 85\%$) when $FR_{max} = 5e-3$. This is a huge gain in performance by simply shuffling the rows. For lower fault rates, HAS is able to recover almost all lost performance.

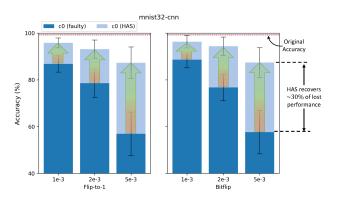


Fig. 7 *HAS* recovers model performance by as much as 30% in *mnist32-cnn* models for Flip-to-1 and Bitflip errors.

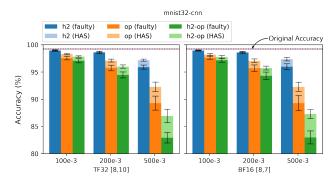


Fig. 8 HAS can recover model accuracy when using reduced precision without any retraining or sophisticated hardware-in-loop optimization. We don't have to use HAS for all layers. Some layers (h0, h1) are quite robust and the amount of recovery from HAS is not worth the computational effort required by GA search.

If we refer to [5], fault rates of 1e-3 correspond to about 50% power savings. Thus, by using *HAS*, we can aggressively lower SRAM voltages and *gain 50% power savings with almost no loss in model accuracy or latency*. This is quite significant, especially when all it costs is to shuffle the rows of the tensors before and after multiplication.

The performance degradation due to mantissa truncation and recovery using HAS for h2 and op layers is shown in Figure 8. HAS recovers 2-4% accuracy points for h2 and op layers individually. When both layers undergo mantissa truncation, it is possible to recover almost 5% accuracy points (h2-op). While this is not as dramatic as the 30% recovery for c0 layer, it still shows that it is possible to recover from some performance degradation when executing models in heterogeneous hardware with mixed precision. It is worth noting we have used extremely unrealistic and severe truncation errors for the sake of generality. During actual implementation, PEs do not sporadically change their precision and they are not randomly scattered throughout the hardware. Rather, they are arranged in a structured manner with controllable deterministic precision scheduling. In such a case, we can expect GA to find a much more optimized solution for much higher performance recovery.

5.2.2 fashion-cnn

The *fashion-cnn* model is much more robust than *mnist32-cnn*. Significant degradation is observed only when error rates reach as high as 500e–3 for Flip-to-1 and Bitflip errors. This translates

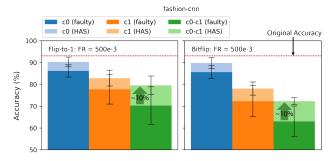


Fig. 9 Even with fault rates as high as 0.5, *HAS* can still recover upto 10% of performance for *fashion-cnn* model.

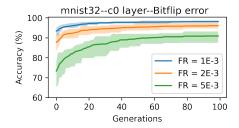


Fig. 10 GA convergence rates for different fault profiles. The rate differs with types of layers, models and fault profiles.

to power savings of approximately 60%. We use HAS to recover some of the lost performance due to errors in c0 and c1, which is shown in Figure 9. We observe that HAS is able to recover about 5% accuracy for each layer individually and around 10% when errors are present in both layers (c0-c1). When errors are present only in c0, we can expect almost full performance recovery. Even at such high error rates, we can expect HAS to recover the performance of the model by simply shuffling the rows. At "lower" fault rates (100e-3, 200e-3) there is little degradation, so using HAS doesn't have any significant improvement.

5.3 GA Convergence

Figure 10 shows how the accuracy of the model improves non-decreasingly as we increase the number of generations for GA optimization. This means that it is possible to get better chromosomes if we let the GA optimization run for longer period of time. This is a major advantage over random search where it is not guaranteed that the solutions will get better as the search progresses. The designer can also decide when to stop the GA optimization. Furthermore, we see that the starting points and the rate of improvement is different for different fault rates, layers and models. Thus, the designer is free to choose different GA parameters when optimizing for different layers/error types and fault profiles.

6. Conclusion and Future Directions

It is possible to extract significant energy gains and reduced latency for DNN computations by using faulty/marginal hardware. Our proposed *HAS: Hardware Agnostic Scheduler* allocates non-critical computations of DNNs to compromised PEs to minimize the performance degradation. It achieves this by shuffling the rows of the matrices during matrix multiplication. The row-shuffling order is determined using GA-based search. With

HAS, we are able to recover up to 30% of classification accuracy for fault rates which correspond to power savings of approximately 50%.

We have focused only on inference in this work. Analyzing the fault sensitivity of different models and architectures during the *training* process is an interesting research avenue. Another promising direction would be to investigate how hardware faults affect other DNN acceleration techniques such as depthwise and pointwise convolutions. Mixed precision arithmetic for training and inference is very popular now-a-days and performance recovery from faults in highly aggressive reduced precision (INT8, INT16) platforms would be very interesting for the research community. In addition, there are many opportunities to refine the hyperparameters for GA. Developing a general GA problem definition methodology for HAS would be extremely helpful when implementing *HAS* in the real world.

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